SFH 4756S

OSLUX®

IR OSLUX (940nm) - 80°







Applications

Access Control (IRIS/Vein Scan, Face Recognition)

Features:

- Corrosion Robustness Class: 3B
- ESD: 2 kV acc. to ANSI/ESDA/JEDEC JS-001 (HBM, Class 2)
- IR lightsource with high efficiency
- Double stack emitter
- Low thermal resistance
- Centroid wavelength 940 nm
- Small outline dimensions

Ordering Information

Туре	Radiant intensity 1)2)	Radiant intensity 1)	Ordering Code
	$I_{p} = 1 \text{ A}; t_{p} = 10 \text{ ms}$	typ. $I_F = 1 \text{ A}; t_p = 10 \text{ ms}; D = 0 ; T_A = 25 °C$	
	e e	l _e	
SFH 4756S	450 850 mW/sr	580 mW/sr	Q65113A0217

Maximum Ratings

 $T_A = 25$ °C

Parameter	Symbol		Values
Operating temperature	T _{op}	min.	-40 °C
		max.	85 °C
Storage temperature	T _{stg}	min.	-40 °C
	olg	max.	85 °C
Junction temperature	T _j	max.	145 °C
Forward current	I _F	max.	1500 mA
Surge current	I _{FSM}	max.	3 A
$t_p \le 1 \text{ ms}; D = 0.005$			
Reverse voltage 3)	V_R		Not designed for reverse operation
Power consumption	P _{tot}	max.	5.4 W
ESD withstand voltage acc. to ANSI/ESDA/JEDEC JS-001 (HBM, Class 2)	V_{ESD}	max.	2 kV

For the forward current and power consumption please see "maximum permissible forward current" diagram



Characteristics

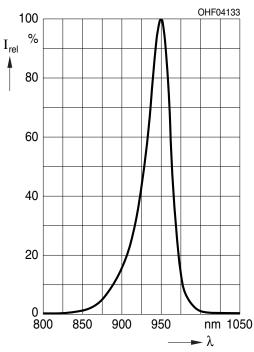
 $I_{\scriptscriptstyle F}$ = 1000 mA; $t_{\scriptscriptstyle p}$ = 10 ms; $T_{\scriptscriptstyle A}$ = 25 °C

Parameter	Symbol		Values
Peak wavelength	λ_{peak}	typ.	950 nm
Centroid wavelength	$\lambda_{ ext{centroid}}$	typ.	940 nm
Spectral bandwidth at 50% I _{rel,max} (FWHM)	Δλ	typ.	37 nm
Half angle	φ	typ.	40 °
Dimensions of active chip area	LxW	typ.	1 x 1 mm x mm
Rise time (10% / 90%) $I_F = 3 \text{ A}; R_L = 50 \Omega$	t _r	typ.	12 ns
Fall time (10% / 90%) $I_F = 3 \text{ A}; R_L = 50 \Omega$	t _f	typ.	15 ns
Forward voltage 4)	V_{F}	typ. max.	2.9 V 3.3 V
Forward voltage $^{4)}$ I _F = 1.5 A; t _p = 100 µs	V _F	typ. max.	3.1 V 3.5 V
Forward voltage $^{4)}$ I _F = 3 A; t _p = 100 µs	V _F	typ. max.	3.5 V 4.1 V
Reverse current 3)	I _R		Not designed for reverse operation
Irradiance $I_F = 1 \text{ A}; t_p = 100 \mu\text{s}$	E _e	typ.	58 mW/cm²
Irradiance $I_F = 1.5 \text{ A}$; $t_p = 100 \mu\text{s}$	E _e	typ.	85 mW/cm²
Total radiant flux $^{5)}$ I _F = 1 A; t _p = 100 µs	Фе	typ.	1000 mW
Total radiant flux $^{5)}$ I _F = 1.5 A; t _p = 100 µs	Фе	typ.	1460 mW
Temperature coefficient of voltage	TC_v	typ.	-2 mV / K
Temperature coefficient of brightness	TC,	typ.	-0.3 % / K
Temperature coefficient of wavelength	TC_{λ}	typ.	0.3 nm / K
Thermal resistance junction solder point real 6)	$R_{ ext{thJS real}}$	max.	14 K / W



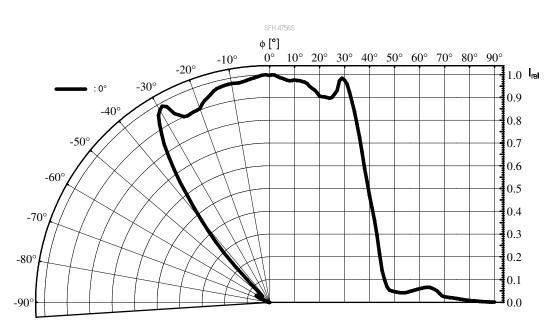
Relative Spectral Emission 7), 8)

 $I_{e,rel} = f(\lambda); I_{F} = 1000 \text{ mA}; t_{p} = 10 \text{ ms}$



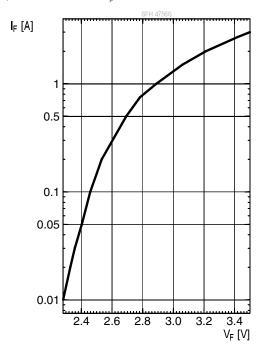
Radiation Characteristics 7), 8)

 $I_{e,rel} = f(\phi)$



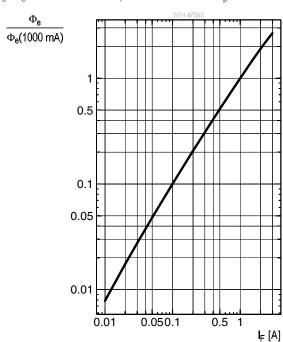
Forward current 7), 8)

 $I_F = f(V_F)$; single pulse; $t_D = 100 \mu s$



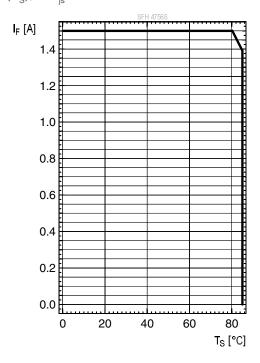
Relative Total Radiant Flux 7), 8)

 $\Phi_{e}/\Phi_{e}(1000\text{mA}) = f(I_{F})$; single pulse; $t_{D} = 100 \mu s$



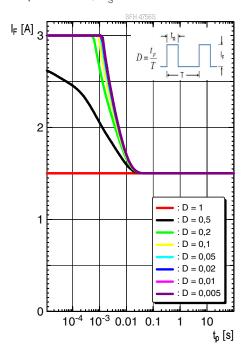
Max. Permissible Forward Current

 $I_{F,max} = f(T_S); Rth_{js} = 14K/W$



Permissible Pulse Handling Capability

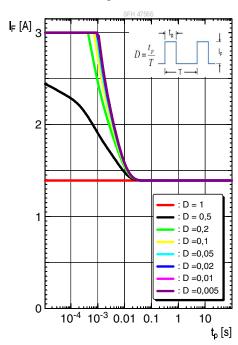
 $I_F = f(t_p)$; D = parameter; $T_S = 25^{\circ}C$



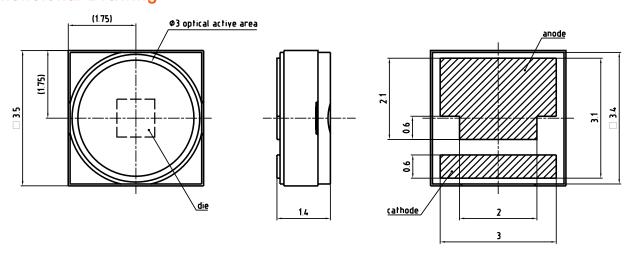


Permissible Pulse Handling Capability

 $I_F = f(t_p)$; D = parameter; $T_S = 85$ °C



Dimensional Drawing 9)



general tolerance ±0.1 lead finish Au

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Further Information:

Approximate Weight: 270.0 mg

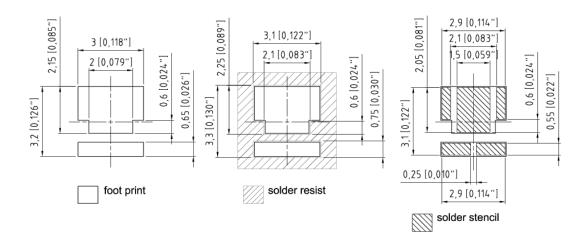
Package marking: Anode

Corrosion test: Class: 3B

Test condition: 40°C / 90 % RH / 15 ppm H₂S / 14 days (stricter than IEC

60068-2-43)

Recommended Solder Pad 9)

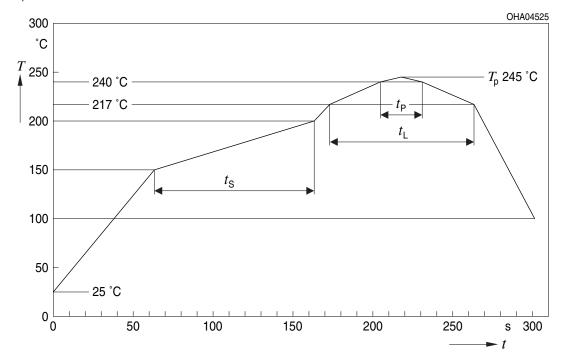


For superior solder joint connectivity results we recommend soldering under standard nitrogen atmosphere. Package not suitable for ultra sonic cleaning.



Reflow Soldering Profile

Product complies to MSL Level 3 acc. to JEDEC J-STD-020E



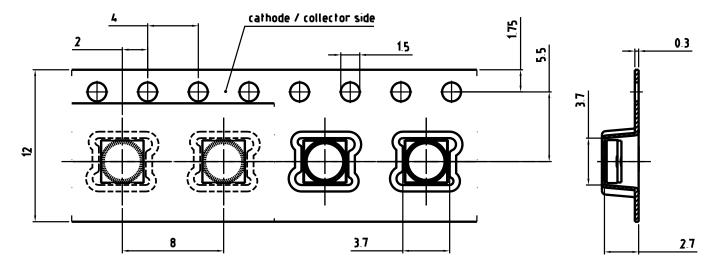
Profile Feature	Symbol	Pb	sembly	Unit	
		Minimum	Recommendation	Maximum	
Ramp-up rate to preheat*)			2	3	K/s
25 °C to 150 °C					
Time t _s	t_s	60	100	120	S
T_{Smin} to T_{Smax}					
Ramp-up rate to peak*)			2	3	K/s
T_{Smax} to T_{P}					
Liquidus temperature	T_L		217		°C
Time above liquidus temperature	$t_{\scriptscriptstyle \perp}$		80	100	S
Peak temperature	T_{P}		245	260	°C
Time within 5 °C of the specified peak	t _P	10	20	30	S
temperature T _P - 5 K					
Ramp-down rate*			3	6	K/s
T _P to 100 °C					
Time				480	S
25 °C to T _P					

All temperatures refer to the center of the package, measured on the top of the component



^{*} slope calculation DT/Dt: Dt max. 5 s; fulfillment for the whole T-range

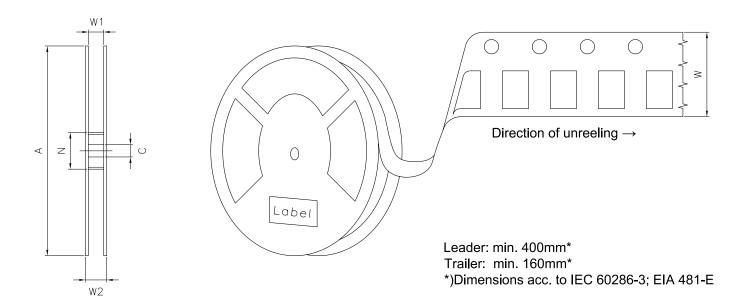
Taping 9)



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Tape and Reel 10)



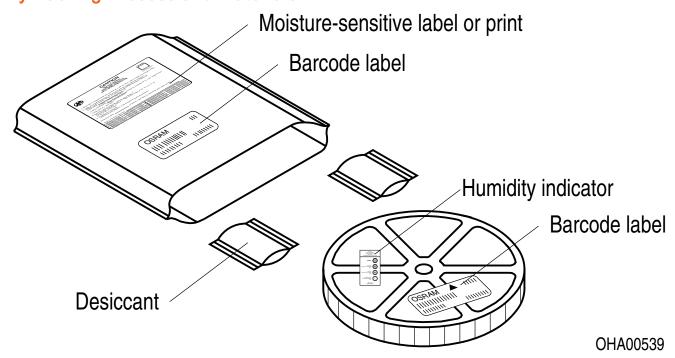
Reel Dimensions

Α	W	N_{\min}	W_1	$W_{2\mathrm{max}}$	Pieces per PU
330 mm	12 + 0.3 / - 0.1 mm	60 mm	12.4 + 2 mm	18.4 mm	2500

Barcode-Product-Label (BPL)



Dry Packing Process and Materials 9)



Moisture-sensitive product is packed in a dry bag containing desiccant and a humidity card according JEDEC-STD-033.



Notes

The evaluation of eye safety occurs according to the standard IEC 62471:2006 (photo biological safety of lamps and lamp systems). Within the risk grouping system of this IEC standard, the device specified in this data sheet fall into the class **exempt group (exposure time 10000 s)**. Under real circumstances (for exposure time, conditions of the eye pupils, observation distance), it is assumed that no endangerment to the eye exists from these devices. As a matter of principle, however, it should be mentioned that intense light sources have a high secondary exposure potential due to their blinding effect. When looking at bright light sources (e.g. headlights), temporary reduction in visual acuity and afterimages can occur, leading to irritation, annoyance, visual impairment, and even accidents, depending on the situation.

Subcomponents of this device contain, in addition to other substances, metal filled materials including silver. Metal filled materials can be affected by environments that contain traces of aggressive substances. Therefore, we recommend that customers minimize device exposure to aggressive substances during storage, production, and use. Devices that showed visible discoloration when tested using the described tests above did show no performance deviations within failure limits during the stated test duration. Respective failure limits are described in the IEC60810.

For further application related information please visit www.osram-os.com/appnotes



Disclaimer

Attention please!

The information describes the type of component and shall not be considered as assured characteristics. Terms of delivery and rights to change design reserved. Due to technical requirements components may contain dangerous substances.

For information on the types in question please contact our Sales Organization.

If printed or downloaded, please find the latest version on the OSRAM OS website.

Packing

Please use the recycling operators known to you. We can also help you – get in touch with your nearest sales office. By agreement we will take packing material back, if it is sorted. You must bear the costs of transport. For packing material that is returned to us unsorted or which we are not obliged to accept, we shall have to invoice you for any costs incurred.

Product and functional safety devices/applications or medical devices/applications

OSRAM OS components are not developed, constructed or tested for the application as safety relevant component or for the application in medical devices.

OSRAM OS products are not qualified at module and system level for such application.

In case buyer – or customer supplied by buyer – considers using OSRAM OS components in product safety devices/applications or medical devices/applications, buyer and/or customer has to inform the local sales partner of OSRAM OS immediately and OSRAM OS and buyer and /or customer will analyze and coordinate the customer-specific request between OSRAM OS and buyer and/or customer.



Glossary

- Radiant intensity: Measured at a solid angle of Ω = 0.01 sr
- Brightness: The brightness values are measured with a tolerance of $\pm 11\%$.
- Reverse Operation: Not designed for reverse operation. Continuous reverse operation can cause migration and damage of the device.
- Forward Voltage: The forward voltages are measured with a tolerance of ±0.1 V.
- ⁵⁾ **Total radiant flux:** Measured with integrating sphere.
- Thermal resistance: junction soldering point, of the device only, mounted on an ideal heatsink (e.g. metal block)
- Typical Values: Due to the special conditions of the manufacturing processes of semiconductor devices, the typical data or calculated correlations of technical parameters can only reflect statistical figures. These do not necessarily correspond to the actual parameters of each single product, which could differ from the typical data and calculated correlations or the typical characteristic line. If requested, e.g. because of technical improvements, these typ. data will be changed without any further notice.
- ⁸⁾ **Testing temperature:** TA = 25°C (unless otherwise specified)
- Tolerance of Measure: Unless otherwise noted in drawing, tolerances are specified with ±0.1 and dimensions are specified in mm.
- ¹⁰⁾ **Tape and Reel:** All dimensions and tolerances are specified acc. IEC 60286-3 and specified in mm.



Revision History			
Version	Date	Change	
1.0	2020-11-27	Initial Version	
1.1	2021-08-04	Not for new design	



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